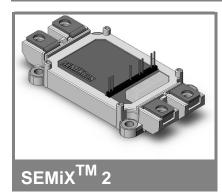
# SEMiX 252GB126HD



### Trench IGBT Modules

#### SEMiX 252GB126HD

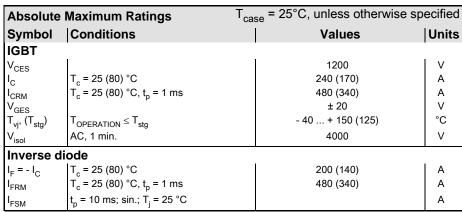
**Target Data** 

#### **Features**

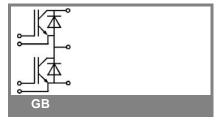
- · Homogeneous Si
- Trench = Trenchgate technology
- V<sub>CE(sat)</sub> with positive temperature coefficient
- · High short circuit capability

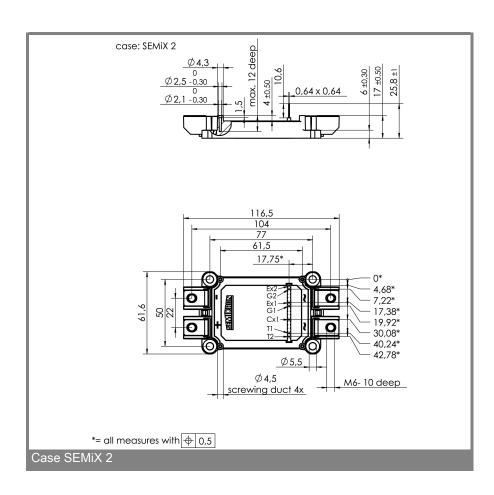
## **Typical Applications**

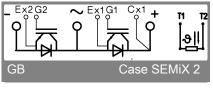
- AC inverter drives
- UPS
- Electronic Welding



Characteristics T <sub>c</sub>		<sub>ase</sub> = 25°C	se = 25°C, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units	
IGBT		•				
V <sub>GE(th)</sub> I <sub>CES</sub>	$V_{GE} = V_{CE}, I_{C} = 6 \text{ mA}$ $V_{GE} = 0, V_{CE} = V_{CES}, T_{j} = 25 (125) ^{\circ}\text{C}$	5	5,8	6,5 1	V mA	
$V_{CE(TO)}$	T <sub>j</sub> = 25 (125) °C		1 (0,9)		V	
$r_{CE}$	V <sub>GE</sub> = 15 V, T <sub>j</sub> = 25 (125) °C		4,7 (7,3)		mΩ	
V <sub>CE(sat)</sub>	I <sub>C</sub> = 150 A, V <sub>GE</sub> = 15 V, T <sub>j</sub> = 25 (125) °C, chip level		1,7 (2)	2,15 (2,45)	V	
C <sub>ies</sub>	under following conditions		10,7		nF	
C <sub>oes</sub>	$V_{GE} = 0, V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}$		0,6		nF	
C <sub>res</sub>			0,5		nF	
L <sub>CE</sub>			18		nH	
R <sub>CC'+EE'</sub>	resistance, terminal-chip, T <sub>c</sub> = 25 (125) °C				mΩ	
t <sub>d(on)</sub> /t <sub>r</sub>	V <sub>CC</sub> = 600 V, I <sub>C</sub> = 150 A				ns	
$t_{d(off)}/t_{f}$	V <sub>GE</sub> = ± 15 V				ns	
$E_{on} (E_{off})$	$R_{Gon} = R_{Goff} = \Omega$ , $T_j = 125  ^{\circ}C$		12,5 (25)		mJ	
Inverse d	liode					
$V_F = V_{EC}$	$I_F$ = 150 A; $V_{GE}$ = 0 V; $T_j$ = 25 (125) °C, chip level		1,6 (1,6)	1,8 (1,8)	V	
$V_{(TO)}$	T <sub>j</sub> = 25 (125) °C		1 (0,8)	, , ,	V	
r <sub>T</sub>	T <sub>j</sub> = 25 (125) °C		4 (5,3)	4,7 (6)	mΩ	
I <sub>RRM</sub>	I <sub>F</sub> = 150 A; T <sub>j</sub> = 25 (125) °C				A	
$Q_{rr}$	di/dt = A/μs				μC	
E <sub>rr</sub>	V <sub>GE</sub> = V				mJ	
	characteristics					
$R_{th(j-c)}$	per IGBT			0,15	K/W	
R <sub>th(j-c)D</sub>	per Inverse Diode			0,3	K/W	
$R_{th(j-c)FD}$	per FWD				K/W	
R <sub>th(c-s)</sub>	per module		0,045		K/W	
Tempera	ture sensor					
R <sub>25</sub>	$T_c = 25 ^{\circ}C$		5 ±5%		kΩ	
B <sub>25/85</sub>	$R_2 = R_1 \exp[B(1/T_2-1/T_1)]$ ; T[K];B		3420		K	
Mechanic	cal data					
$M_s/M_t$	to heatsink (M5) / for terminals (M6)	3/2,5		5 /5	Nm	
w			236		g	







This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.